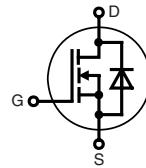


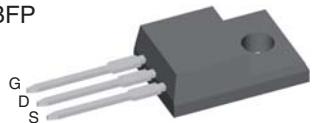
CoolMOS Power MOSFET

Fully isolated package
N-Channel Enhancement Mode
Low $R_{DS(on)}$, High V_{DSS} MOSFET
Ultra low gate charge

$I_{D25} = 5.4 \text{ A}$
 $V_{DSS} = 600 \text{ V}$
 $R_{DS(on) \max} = 0.385 \Omega$



TO-220 ABFP
COOLMOS
Power Semiconductors



MOSFET

Symbol	Conditions	Maximum Ratings		
V_{DSS}	$T_{VJ} = 25^\circ\text{C}$	600	V	
V_{GS}		± 20	V	
I_{D25}	$T_C = 25^\circ\text{C}$	5.4	A	
I_{D90}	$T_C = 90^\circ\text{C}$	3.7	A	
E_{AS}	single pulse	225	mJ	
E_{AR}	repetitive } $I_D = 3.4 \text{ A}; T_C = 25^\circ\text{C}$	0.3	mJ	
dV/dt	MOSFET dV/dt ruggedness $V_{DS} = 0 \dots 480 \text{ V}$	50	V/ns	

Symbol Conditions Characteristic Values

($T_{VJ} = 25^\circ\text{C}$, unless otherwise specified)

		min.	typ.	max.
$R_{DS(on)}$	$V_{GS} = 10 \text{ V}; I_D = 5.2 \text{ A}$	350	385	$\text{m}\Omega$
$V_{GS(\text{th})}$	$V_{DS} = V_{GS}; I_D = 0.34 \text{ mA}$	2.5	3	3.5
I_{DSS}	$V_{DS} = 600 \text{ V}; V_{GS} = 0 \text{ V}$ $T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	tbd	1	μA
I_{GSS}	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$		100	nA
C_{iss}	$V_{GS} = 0 \text{ V}; V_{DS} = 100 \text{ V}$	790		pF
C_{oss}	$f = 1 \text{ MHz}$	38		pF
Q_g	$V_{GS} = 0 \text{ to } 10 \text{ V}; V_{DS} = 400 \text{ V}; I_D = 5.2 \text{ A}$	17	22	nC
Q_{gs}		4		nC
Q_{gd}		6		nC
$t_{d(on)}$	$V_{GS} = 10 \text{ V}; V_{DS} = 400 \text{ V}$ $I_D = 5.2 \text{ A}; R_G = 4.3 \Omega$	tbd		ns
t_r		tbd		ns
$t_{d(off)}$		tbd		ns
t_f		tbd		ns
R_{thJC}			3.95	K/W

Features

- Fast CoolMOS power MOSFET - 4th generation
 - High blocking capability
 - Lowest resistance
 - Avalanche rated for unclamped inductive switching (UIS)
- Fully isolated package

Applications

- Switched mode power supplies (SMPS)
- Uninterruptible power supplies (UPS)
- Power factor correction (PFC)
- Welding
- Inductive heating
- PDP and LCD adapter

CoolMOS is a trademark of Infineon Technologies AG.

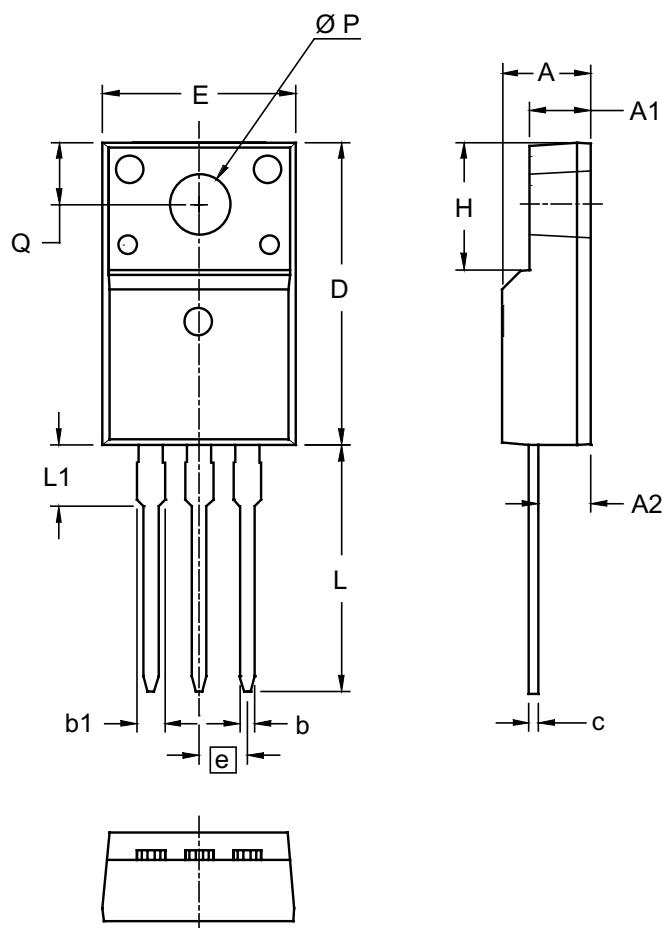
Source-Drain Diode

Symbol	Conditions	Characteristic Values		
		(T _{VJ} = 25°C, unless otherwise specified)		
		min.	typ.	max.
I _s	V _{GS} = 0 V			5.2 A
V _{SD}	I _F = 5.2 A; V _{GS} = 0 V	0.9	1.2	V
t _{rr} Q _{RM} I _{RM}	I _F = 5.2 A; -di _F /dt = 100 A/μs; V _R = 400 V	260		ns
		21		μC
		24		A

Component

Symbol	Conditions	Maximum Ratings		
T _{VJ}	operating	-40...+150	°C	
T _{stg}		-40...+150	°C	
M _d	mounting torque	0.4 ... 0.6	Nm	
Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
R _{thCH}	with heatsink compound	0.50		K/W
R _{thJA}		80		K/W
Weight		2		g

TO-220 ABFP Outline



SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.177	.193	4.50	4.90
A1	.092	.108	2.34	2.74
A2	.101	.117	2.56	2.96
b	.028	.035	0.70	0.90
b1	.050	.058	1.27	1.47
c	.018	.024	0.45	0.60
D	.617	.633	15.67	16.07
E	.392	.408	9.96	10.36
e	.100 BSC		2.54 BSC	
H	.255	.271	6.48	6.88
L	.499	.523	12.68	13.28
L1	.119	.135	3.03	3.43
ØP	.121	.129	3.08	3.28
Q	.126	.134	3.20	3.40

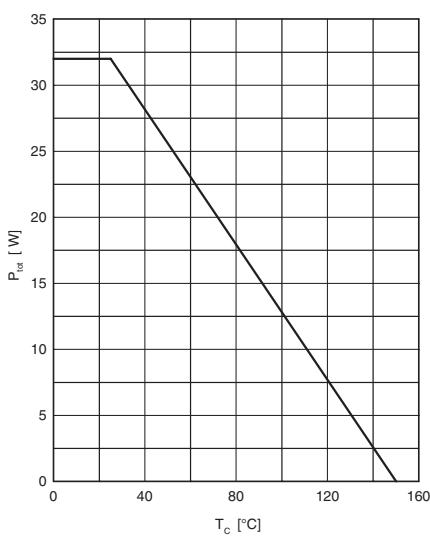


Fig. 1 Power dissipation

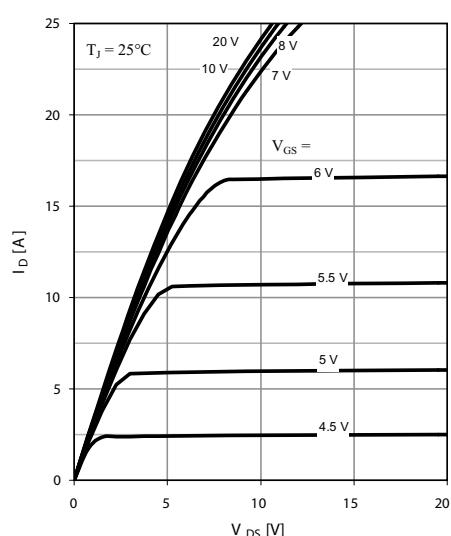


Fig. 2 Typ. output characteristics

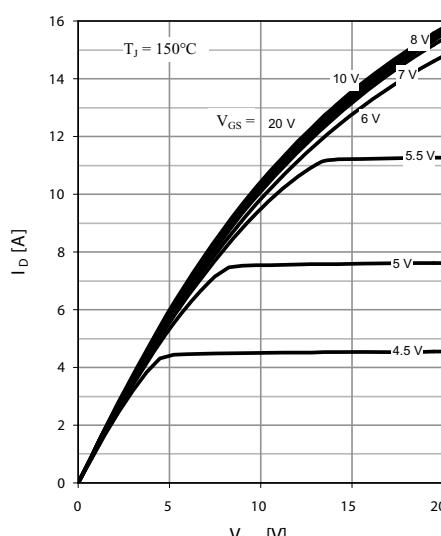


Fig. 3 Typ. output characteristics

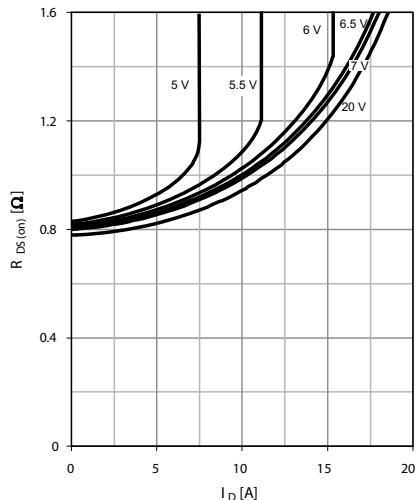


Fig. 3 Typ. drain-source on-state resistance characteristics of IGBT

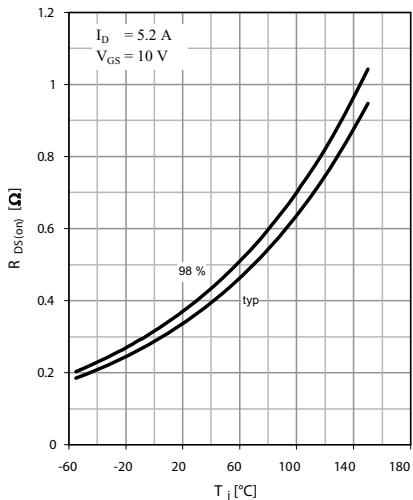


Fig. 4 Drain-source on-state resistance

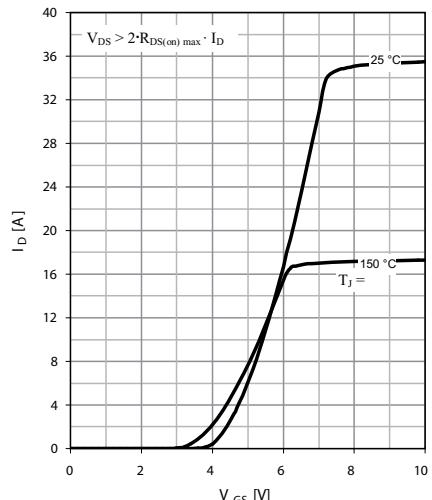


Fig. 5 Typ. transfer characteristics

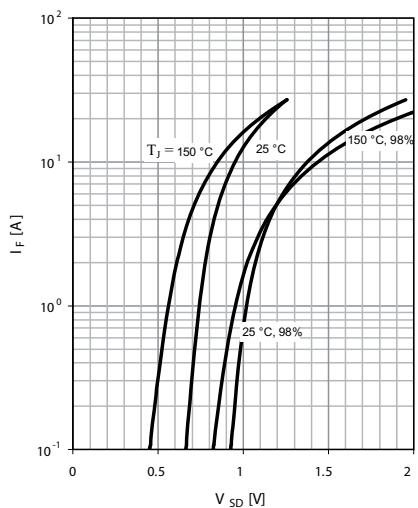


Fig. 6 Forward characteristic of reverse diode

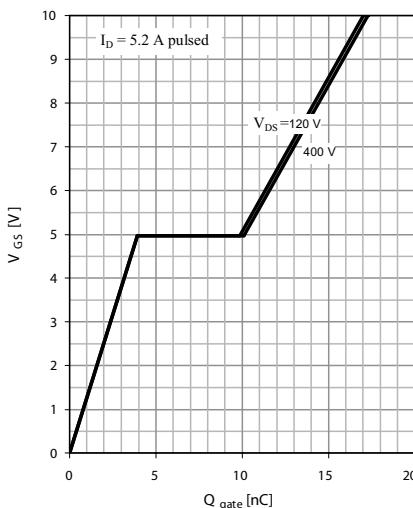


Fig. 7 Typ. gate charge

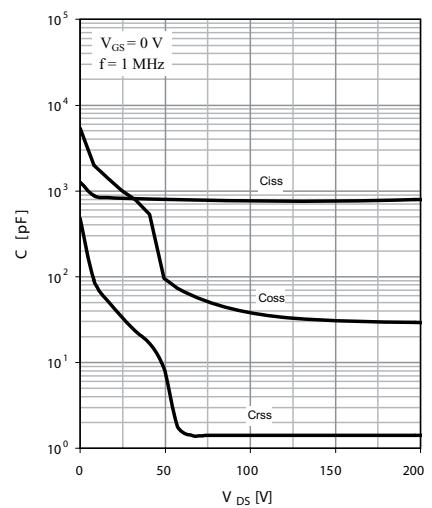


Fig. 8 Typ. capacitances

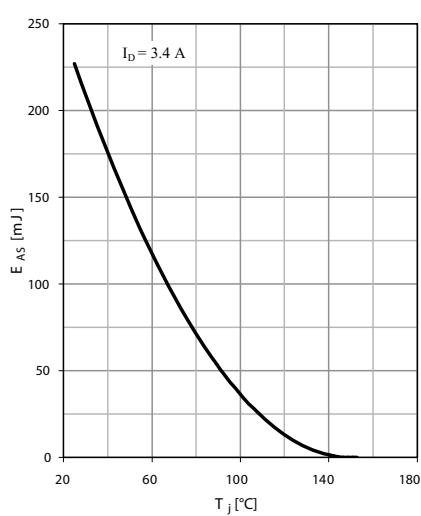


Fig. 9 Avalanche energy

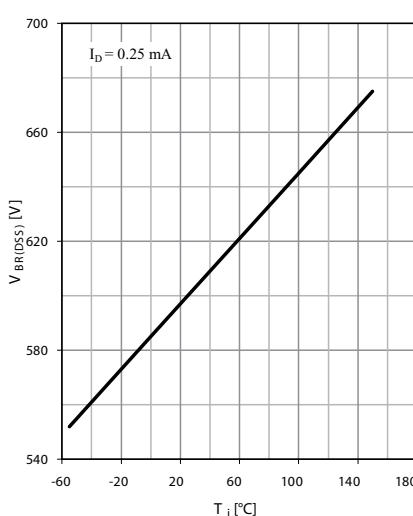


Fig. 10 Drain-source breakdown voltage

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